

10/589679

AP6 Rec'd PCT/PTO 16 AUG 2006

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Hiroto HORIKAWA

Application No.: New U.S. Patent Application

Filed: August 16, 2006

Docket No.: 129109

For: EXPOSURE APPARATUS, EXPOSURE METHOD, AND DEVICE FABRICATING METHOD

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

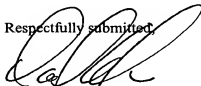
Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 20, 29, 32, 38-50 and 57.
- ☒ 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See References 7, 8 and 51-56.
- ☒ 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- ☒ 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 20, 26-42, 44-49 and 51-57.

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- ☒ 6. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office (<http://www.jpo.go.jp>), and is attached, but has not been reviewed for accuracy. See References 31, 38, 40-43, 45, 46, 48, 49, 53, 54, 56 and 57.
- ☒ 7. References 40, 44, 45, 46, 57 correspond to references 13, 17, 18, 19, 9, respectively. References 41 and 42 correspond to reference 14. Reference 43 corresponds to references 15 and 16.

Respectfully submitted,



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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129109		APPLICATION NO. New U.S. Patent Application 10/589679	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hiroto HORIKAWA		GROUP	
				FILING DATE August 16, 2006			
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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /M.A./

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